

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/825,816	KIM ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Chuc D. Tran	2821	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,563,631	05-2003	Delprat et al.	359/344
*	B	US-6,806,114	10-2004	Lo, Yu-Hwa	438/36
*	C	US-6,252,895	06-2001	Nitta et al.	372/50.1
*	D	US-7,010,009	03-2006	Kim, Jong-Ryeol	372/43.01
*	E	US-5,177,758	01-1993	Oka et al.	372/50.11
*	F	US-5,140,149	08-1992	Sakata et al.	257/436
*	G	US-5,946,336	08-1999	Mizutani et al.	372/50.1
*	H	US-6,751,013	06-2004	Wu, Yongan	359/337
*	I	US-5,239,410	08-1993	Nishimura et al.	359/344
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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